

Features

- AEC-Q100 with extended temperature range (-55°C to 125°C)
- Frequencies between 1 MHz and 110 MHz accurate to 6 decimal places
- Supply voltage of 1.8V or 2.25V to 3.63V
- Excellent total frequency stability as low as ±25 ppm
- Industry best G-sensitivity of 0.1 PPB/G
- Low power consumption of 3.8 mA typical at 1.8V
- LVCMOS/LVTTL compatible output
- 5-pin SOT23-5 package: 2.9 x 2.8 mm x mm
- RoHS and REACH compliant, Pb-free, Halogen-free and Antimony-free

Electrical Specifications

Table 1. Electrical Characteristics^[1, 2]

Applications

- Automotive, extreme temperature and other high-rel electronics
- Infotainment systems, collision detection devices, and in-vehicle networking
- Power train control



		Тур.		Unit	Condition
		F	requency R	ange	
f	1	-	110	MHz	Refer to Table 13 and Table 14 for a list supported frequencies
		Frequer	ncy Stability	and Aging	3
F_stab	-25	-	+25	ppm	Inclusive of Initial tolerance at 25°C, 1st year aging at 25°C, and
	-30	-	+30	ppm	variations over operating temperature, rated power supply voltage and load (15 pF \pm 10%).
	-50	-	+50	ppm	
		Operati	ng Tempera	ture Range	9
T_use	-40	-	+105	°C	Extended Industrial, AEC-Q100 Grade 2
	-40	-	+125	°C	Automotive, AEC-Q100 Grade 1
	-55	-	+125	°C	Extended Temperature, AEC-Q100
	Si	upply Voltag	je and Curr	ent Consur	nption
Vdd	1.62	1.8	1.98	V	All voltages between 2.25V and 3.63V including 2.5V, 2.8V, 3.0V
	2.25	-	3.63	V	and 3.3V are supported.
Idd	-	4.0	4.8	mA	No load condition, f = 20 MHz, Vdd = 2.25V to 3.63V
	-	3.8	4.5	mA	No load condition, f = 20 MHz, Vdd = 1.8V
		LVCMOS	Output Ch	aracteristic	CS
DC	45	-	55	%	All Vdds
Tr, Tf	-	1.5	3	ns	Vdd = 2.25V - 3.63V, 20% - 80%
	-	1.3	2.5	ns	Vdd = 1.8V, 20% - 80%
VOH	90%	_	-	Vdd	IOH = -4 mA (Vdd = 3.0V or 3.3V) IOH = -3 mA (Vdd = 2.8V and Vdd = 2.5V) IOH = -2 mA (Vdd = 1.8V)
VOL	-	-	10%	Vdd	IOL = 4 mA (Vdd = 3.0V or 3.3V) IOL = 3 mA (Vdd = 2.8V and Vdd = 2.5V) IOL = 2 mA (Vdd = 1.8V)
		Inp	ut Characte	eristics	
VIH	70%	-	-	Vdd	Pin 1, OE
VIL	-	-	30%	Vdd	Pin 1, OE
Z_in	-	100	-	kΩ	Pin 1, OE logic high or logic low
		Startu	o and Resu	me Timing	
T_start	_	-	10	ms	Measured from the time Vdd reaches 90% of final value
T_oe	_	-	130	ns	f = 110 MHz. For other frequencies, T_oe = 100 ns + 3 * cycles
<u> </u>		1	Jitter		
T_jitt	_	1.6	2.5	ps	f = 75 MHz, 2.25V to 3.63V
	-	1.9	3.0	ps	f = 75 MHz, 1.8V
T phj	_	0.5	_	· ·	f = 75 MHz, Integration bandwidth = 900 kHz to 7.5 MHz
	_		_		f = 75 MHz, Integration bandwidth = 12 kHz to 20 MHz
	F_stab T_use Vdd Idd DC Tr, Tf VOH VOL VIH VIL Z_in T_oe	F_stab -25 -30 -50 T_use -40 -40 -55 Vdd 1.62 2.25 1dd Idd - DC 45 Tr, Tf - VOH 90% VOL - VIH 70% VIL - Tstart - Toe - Tphj -	Frequer F_stab -25 - -30 - - -30 - - -50 - Operati T_use -40 - -40 - - -55 - - Vdd 1.62 1.8 2.25 - - Idd - 4.0 - 3.8 - DC 45 - Tr, Tf - 1.5 - 1.3 VOH 90% - VOL - - - VVOL - - - VUH 70% - - VIH 70% - - VIL - - - T_oe - - - T_itt - 1.6 - T_phj - 0.5	Frequency Stability F_stab -25 $ +25$ -30 $ +30$ -50 $ +50$ Operating Temperating Temper	Frequency Stability and Aging -25 F_stab -25 - +25 ppm -30 - +30 ppm -30 - +30 ppm -50 - +50 ppm Operating Temperature Range T_use -40 - +105 °C -40 - +125 °C -55 - +125 °C -50 - +125 °C -55 - +125 °C Supply Voltage and Current Consum Vdd 1.62 1.8 1.98 V 2.25 - 3.63 V V 2.25 mA mA - 3.8 4.5 mA mA mA mA - 3.8 4.5 mA mA mA mA - 1.5 3 ns mS mA UC - - 10% Vdd

Notes:

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1. All electrical specifications in the above table are specified with 15 pF output load and for all Vdd(s) unless otherwise stated.

2. The typical value of any parameter in the Electrical Characteristics table is specified for the nominal value of the highest voltage option for that parameter and at 25 °C temperature.



Table 2. Pin Description

Pin	Symbol	Functionality			
1	GND	Power	Electrical ground ^[4]		
2	NC	No Connect	No connect		
3	OE/ NC	Output Enable	H ^[3] : specified frequency output L: output is high impedance. Only output driver is disabled.		
5		No Connect	Any voltage between 0 and Vdd or Open ^[3] : Specified frequency output. Pin 3 has no function.		
4	VDD	Power	Power supply voltage ^[4]		
5	OUT	Output	Oscillator output		



Figure 1. Pin Assignments

Notes:

3. In OE or ST mode, a pull-up resistor of 10 k Ω or less is recommended if pin 3 is not externally driven. If pin 3 needs to be left floating, use the NC option. 4. A capacitor of value 0.1 μ F or higher between Vdd and GND is required.

Table 3. Absolute Maximum Limits

Attempted operation outside the absolute maximum ratings may cause permanent damage to the part. Actual performance of the IC is only guaranteed within the operational specifications, not at absolute maximum ratings.

Parameter	Min.	Max.	Unit
Storage Temperature	-65	150	°C
Vdd	-0.5	4	V
Electrostatic Discharge	-	2000	V
Soldering Temperature (follow standard Pb free soldering guidelines)	-	260	°C
Junction Temperature ^[5]	-	150	°C

Note:

5. Exceeding this temperature for extended period of time may damage the device.

Table 4. Thermal Consideration^[6]

Package	θJA, 4 Layer Board (°C/W)	θJC, Bottom (°C/W)
SOT23-5	421	175

Note:

6. Refer to JESD51 for 0JA and 0JC definitions, and reference layout used to determine the 0JA and 0JC values in the above table.

Table 5. Maximum Operating Junction Temperature^[7]

Max Operating Temperature (ambient)	Maximum Operating Junction Temperature
105°C	115°C
125°C	135°C

Note:

7. Datasheet specifications are not guaranteed if junction temperature exceeds the maximum operating junction temperature.

Table 6. Environmental Compliance

Parameter	Condition/Test Method
Mechanical Shock	MIL-STD-883F, Method 2002
Mechanical Vibration	MIL-STD-883F, Method 2007
Temperature Cycle	JESD22, Method A104
Solderability	MIL-STD-883F, Method 2003
Moisture Sensitivity Level	MSL1 @ 260°C



Test Circuit and Waveform^[8]



Figure 2. Test Circuit





Note:

8. Duty Cycle is computed as Duty Cycle = TH/Period.

Timing Diagrams



Figure 4. Startup Timing (OE Mode)



T_oe: Time to put the output in High Z mode

Figure 6. OE Disable Timing (OE Mode Only)

Note:

9. SiT2024 has "no runt" pulses and "no glitch" output during startup or resume.



T_oe: Time to re-enable the clock output

Figure 5. OE Enable Timing (OE Mode Only)

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Performance Plots^[10]



Figure 7. Idd vs Frequency



Figure 9. RMS Period Jitter vs Frequency



Figure 11. 20%-80% Rise Time vs Temperature



Figure 8. Frequency vs Temperature



Figure 10. Duty Cycle vs Frequency



Figure 12. 20%-80% Fall Time vs Temperature



Performance Plots^[10]



Notes:

10. All plots are measured with 15 pF load at room temperature, unless otherwise stated.

11. Phase noise plots are measured with Agilent E5052B signal source analyzer. Integration range is up to 5 MHz for carrier frequencies below 40 MHz.



The SiT2024 includes a programmable drive strength feature to provide a simple, flexible tool to optimize the clock rise/fall time for specific applications. Benefits from the programmable drive strength feature are:

- Improves system radiated electromagnetic interference (EMI) by slowing down the clock rise/fall time.
- Improves the downstream clock receiver's (RX) jitter by decreasing (speeding up) the clock rise/fall time.
- Ability to drive large capacitive loads while maintaining full swing with sharp edge rates.

For more detailed information about rise/fall time control and drive strength selection, see the SiTime Application Notes section; <u>http://www.sitime.com/support/application-notes.</u>

EMI Reduction by Slowing Rise/Fall Time

Figure 16 shows the harmonic power reduction as the rise/fall times are increased (slowed down). The rise/fall times are expressed as a ratio of the clock period. For the ratio of 0.05, the signal is very close to a square wave. For the ratio of 0.45, the rise/fall times are very close to near-triangular waveform. These results, for example, show that the 11th clock harmonic can be reduced by 35 dB if the rise/fall edge is increased from 5% of the period to 45% of the period.



Figure 16. Harmonic EMI reduction as a Function of Slower Rise/Fall Time

Jitter Reduction with Faster Rise/Fall Time

Power supply noise can be a source of jitter for the downstream chipset. One way to reduce this jitter is to speed up the rise/fall time of the input clock. Some chipsets may also require faster rise/fall time in order to reduce their sensitivity to this type of jitter. Refer to the Rise/Fall Time Tables (Table 7 to Table 11) to determine the proper drive strength.

High Output Load Capability

The rise/fall time of the input clock varies as a function of the actual capacitive load the clock drives. At any given drive strength, the rise/fall time becomes slower as the output load increases. As an example, for a 3.3V SiT2024 device with default drive strength setting, the typical rise/fall time is 1 ns for 15 pF output load. The typical rise/fall time slows down to 2.6 ns when the output load increases to 45 pF. One can choose to speed up the rise/fall time to 1.83 ns by then increasing the drive strength setting on the SiT2024.

The SiT2024 can support up to 60 pF in maximum capacitive loads with drive strength settings. Refer to the Rise/Tall Time Tables (Table 7 to 11) to determine the proper drive strength for the desired combination of output load vs. rise/fall time.

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SiT2024 Drive Strength Selection

Tables 7 through 11 define the rise/fall time for a given capacitive load and supply voltage.

- 1. Select the table that matches the SiT2024 nominal supply voltage (1.8V, 2.5V, 2.8V, 3.0V, 3.3V).
- 2. Select the capacitive load column that matches the application requirement (5 pF to 60 pF)
- 3. Under the capacitive load column, select the desired rise/fall times.
- 4. The left-most column represents the part number code for the corresponding drive strength.
- 5. Add the drive strength code to the part number for ordering purposes.

Calculating Maximum Frequency

Based on the rise and fall time data given in Tables 7 through 11, the maximum frequency the oscillator can operate with guaranteed full swing of the output voltage over temperature can be calculated as:

Max Frequency =
$$\frac{1}{5 \times Trf_{20/80}}$$

where Trf_20/80 is the typical value for 20%-80% rise/fall time.

Example 1

Calculate f_{MAX} for the following condition:

- Vdd = 3.3V (Table 7)
- · Capacitive Load: 30 pF
- Desired Tr/f time = 1.31 ns (rise/fall time part number code = F)

Part number for the above example: SiT2024AAES2-18E-66.666660



Drive strength code is inserted here. Default setting is "-"



Rise/Fall Time (20% to 80%) vs $\rm C_{\rm LOAD}$ Tables

Table 7. Vdd = 1.8V Rise/Fall Times for Specific C_{LOAD}

Rise/Fall Time Typ (ns)								
Drive Strength $\ C_{LOAD}$	Drive Strength \ C _{LOAD} 5 pF 15 pF 30 pF 45 pF 60 pF							
L	6.16	11.61	22.00	31.27	39.91			
А	3.19	6.35	11.00	16.01	21.52			
R	2.11	4.31	7.65	10.77	14.47			
В	1.65	3.23	5.79	8.18	11.08			
Т	0.93	1.91	3.32	4.66	6.48			
E	0.78	1.66	2.94	4.09	5.74			
U	0.70	1.48	2.64	3.68	5.09			
F or "-": default	0.65	1.30	2.40	3.35	4.56			

Table 8. Vdd = 2.5V Rise/Fall Times for Specific CLOAD

Rise/Fall Time Typ (ns)						
Drive Strength $\ C_{LOAD}$	5 pF	15 pF	30 pF	45 pF	60 pF	
L	4.13	8.25	12.82	21.45	27.79	
Α	2.11	4.27	7.64	11.20	14.49	
R	1.45	2.81	5.16	7.65	9.88	
В	1.09	2.20	3.88	5.86	7.57	
Т	0.62	1.28	2.27	3.51	4.45	
E or "-": default	0.54	1.00	2.01	3.10	4.01	
U	0.43	0.96	1.81	2.79	3.65	
F	0.34	0.88	1.64	2.54	3.32	

Table 9. Vdd = 2.8V Rise/Fall Times for Specific C_{LOAD}

Rise/Fall Time Typ (ns)						
Drive Strength \ C _{LOAD}	5 pF	15 pF	30 pF	45 pF	60 pF	
L	3.77	7.54	12.28	19.57	25.27	
Α	1.94	3.90	7.03	10.24	13.34	
R	1.29	2.57	4.72	7.01	9.06	
В	0.97	2.00	3.54	5.43	6.93	
Т	0.55	1.12	2.08	3.22	4.08	
E or "-": default	0.44	1.00	1.83	2.82	3.67	
U	0.34	0.88	1.64	2.52	3.30	
F	0.29	0.81	1.48	2.29	2.99	

Table 10. Vdd = 3.0V Rise/Fall Times for Specific C_{LOAD}

Rise/Fall Time Typ (ns)							
Drive Strength \ C _{LOAD}	5 pF 15 pF 30 pF 45 pF 60 pF						
L	3.60	7.21	11.97	18.74	24.30		
Α	1.84	3.71	6.72	9.86	12.68		
R	1.22	2.46	4.54	6.76	8.62		
В	0.89	1.92	3.39	5.20	6.64		
T or "-": default	0.51	1.00	1.97	3.07	3.90		
E	0.38	0.92	1.72	2.71	3.51		
U	0.30	0.83	1.55	2.40	3.13		
F	0.27	0.76	1.39	2.16	2.85		

Table 11. Vdd = 3.3V Rise/Fall Times for Specific C_{LOAD}

Rise/Fall Time Typ (ns)							
Drive Strength \ C _{LOAD}	5 pF 15 pF 30 pF 45 pF 60 pF						
L	3.39	6.88	11.63	17.56	23.59		
А	1.74	3.50	6.38	8.98	12.19		
R	1.16	2.33	4.29	6.04	8.34		
В	0.81	1.82	3.22	4.52	6.33		
T or "-": default	0.46	1.00	1.86	2.60	3.84		
E	0.33	0.87	1.64	2.30	3.35		
U	0.28	0.79	1.46	2.05	2.93		
F	0.25	0.72	1.31	1.83	2.61		



Pin 3 Configuration Options (OE or NC)

Pin 3 of the SiT2024 can be factory-programmed to support three modes: Output Enable (OE) or No Connect (NC).

Output Enable (OE) Mode

In the OE mode, applying logic low to the OE pin only disables the output driver and puts it in Hi-Z mode. The core of the device continues to operate normally. Power consumption is reduced due to the inactivity of the output. When the OE pin is pulled High, the output is typically enabled in <1µs.

No Connect (NC) Mode

In the NC mode, the device always operates in its normal mode and outputs the specified frequency regardless of the logic level on pin 3.

Table 12 below summarizes the key relevant parameters in the operation of the device in OE or NC mode.

Table 12. OE vs. NC

	OE	NC
Active current 20 MHz (max, 1.8V)	4.5 mA	4.5 mA
OE disable current (max. 1.8V)	3.8 mA	N/A
OE enable time at 110 MHz (max)	130 ns	N/A
Output driver in OE disable	High Z	N/A

Output on Startup and Resume

The SiT2024 comes with gated output. Its clock output is accurate to the rated frequency stability within the first pulse from initial device startup.

In addition, the SiT2024 supports "no runt" pulses and "no glitch" output during startup or when the output driver is

re-enabled from the OE disable mode as shown in the waveform captures in Figure 17 and Figure 18.



Figure 17. Startup Waveform vs. Vdd



Figure 18. Startup Waveform vs. Vdd (Zoomed-in View of Figure 17)



Dimensions and Patterns



Notes:

12. Top marking: Y denotes manufacturing origin and XXXX denotes manufacturing lot number. The value of "Y" will depend on the assembly location of the device. 13. A capacitor value of 0.1 µF between Vdd and GND is required

Symbol	Min.	Nom. Max.		
A	0.90	1.25	1.45	
A1	0.00	0.05	0.15	
A2	0.90	1.10	1.30	
b	0.35	0.40	0.50	
с	0.08	0.15	0.20	
D	2.80	2.90	3.00	
E	2.60	2.80	3.00	
E1	1.50	1.625 1.75		
L	0.35	0.45 0.60		
L1	0.60 REF			
е	0.95 BSC.			
e1	1.90 BSC.			
α	0°	2.5° 8°		

Table 13. Dimension Table



The Part No. Guide is for reference only. To customize and build an exact part number, use the SiTime Part Number Generator.



Note:

14. The voltage portion of the SiT2024 part number consists of two characters that denote the specific supply voltage of the device. The SiT2024 supports either 1.8V ±10% or any voltage between 2.25V and 3.62V. In the 1.8V mode, one can simply insert 18 in the part number. In the 2.5V to 3.3V mode, two digits such as 18, 25 or 33 can be used in the part number to reflect the desired voltage. Alternatively, "XX" can be used to indicate the entire operating voltage range from 2.25V to 3.63V.

Table 14. Supported Frequencies (-40°C to $\pm 105^{\circ}$ C or -40°C to $\pm 125^{\circ}$ C)^[15, 16]

Frequency Range			
Min.	Max.		
1.000000 MHz	61.222999 MHz		
61.674001 MHz	69.795999 MHz		
70.485001 MHz	79.062999 MHz		
79.162001 MHz	81.427999 MHz		
82.232001 MHz	91.833999 MHz		
92.155001 MHz	94.248999 MHz		
94.430001 MHz	94.874999 MHz		
94.994001 MHz	97.713999 MHz		
98.679001 MHz	110.000000 MHz		

Table 15. Supported Frequencies $(-55^{\circ}C \text{ to } \pm 125^{\circ}C)^{[15, 16]}$

Frequency Range			
Min.	Max.		
1.000000 MHz	61.222999 MHz		
61.674001 MHz	69.239999 MHz		
70.827001 MHz	78.714999 MHz		
79.561001 MHz	80.159999 MHz		
80.174001 MHz	80.779999 MHz		
82.632001 MHz	91.833999 MHz		
95.474001 MHz	96.191999 MHz		
96.209001 MHz	96.935999 MHz		
99.158001 MHz	110.000000 MHz		

Notes:

15. Any frequency within the min and max values in the above table are supported with 6 decimal places of accuracy.

16. Please contact SiTime for frequencies that are not listed in the tables above.

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Table 16. Additional Information

Document	Description	Download Link
Time Machine II	MEMS oscillator programmer	http://www.sitime.com/support/time-machine-oscillator-programmer
Field Programmable Oscillators	Devices that can be programmable in the field by Time Machine II	http://www.sitime.com/products/field-programmable-oscillators
Manufacturing Notes	Tape & Reel dimension, reflow profile and other manufac- turing related info	http://www.sitime.com/component/docman/doc_download/243-manufacturing-notes-for-sitime-oscillators
Qualification Reports	RoHS report, reliability reports, composition reports	http://www.sitime.com/support/quality-and-reliability
Performance Reports	Additional performance data such as phase noise, current consumption and jitter for selected frequencies	http://www.sitime.com/support/performance-measurement-report
Termination Techniques	Termination design recommendations	http://www.sitime.com/support/application-notes
Layout Techniques	Layout recommendations	http://www.sitime.com/support/application-notes

Revision History

Table 17. Datasheet Version and Change Log

Version	Release Date	Change Summary
0.95	1/29/14	Preliminary
0.96	2/5/14	Added -55°C to 125°C support
1.0	5/28/15	 Final production release Revised Timing Diagrams Fixed error link Revised SOT23 package diagram

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Supplemental Information

The Supplemental Information section is not part of the datasheet and is for informational purposes only.



Silicon MEMS Outperforms Quartz



Best Reliability

Silicon is inherently more reliable than quartz. Unlike quartz suppliers, SiTime has in-house MEMS and analog CMOS expertise, which allows SiTime to develop the most reliable products. Figure 1 shows a comparison with quartz technology.

Why is SiTime Best in Class:

- SiTime's MEMS resonators are vacuum sealed using an advanced EpiSeal[™] process, which eliminates foreign particles and improves long term aging and reliability
- · World-class MEMS and CMOS design expertise



Figure 1. Reliability Comparison^[1]

Best Aging

Unlike quartz, MEMS oscillators have excellent long term aging performance which is why every new SiTime product specifies 10-year aging. A comparison is shown in Figure 2.

Why is SiTime Best in Class:

- SiTime's MEMS resonators are vacuum sealed using an advanced EpiSeal process, which eliminates foreign particles and improves long term aging and reliability
- Inherently better immunity of electrostatically driven MEMS resonator



Figure 2. Aging Comparison^[2]

Best Electro Magnetic Susceptibility (EMS)

SiTime's oscillators in plastic packages are up to 54 times more immune to external electromagnetic fields than quartz oscillators as shown in Figure 3.

Why is SiTime Best in Class:

- Internal differential architecture for best common mode noise rejection
- Electrostatically driven MEMS resonator is more immune to EMS



Figure 3. Electro Magnetic Susceptibility (EMS)^[3]

Best Power Supply Noise Rejection

SiTime's MEMS oscillators are more resilient against noise on the power supply. A comparison is shown in Figure 4.

Why is SiTime Best in Class:

- On-chip regulators and internal differential architecture for common mode noise rejection
- · Best analog CMOS design expertise



Figure 4. Power Supply Noise Rejection^[4]



Best Vibration Robustness

High-vibration environments are all around us. All electronics, from handheld devices to enterprise servers and storage systems are subject to vibration. Figure 5 shows a comparison of vibration robustness.

Why is SiTime Best in Class:

- The moving mass of SiTime's MEMS resonators is up to 3000 times smaller than quartz
- Center-anchored MEMS resonator is the most robust design



Figure 5. Vibration Robustness^[5]

Notes:

- 1. Data Source: Reliability documents of named companies.
- 2. Data source: SiTime and quartz oscillator devices datasheets.
- 3. Test conditions for Electro Magnetic Susceptibility (EMS):
 - According to IEC EN61000-4.3 (Electromagnetic compatibility standard)
 Eicle stage stage 20//stage
 - Field strength: 3V/m
 - Radiated signal modulation: AM 1 kHz at 80% depth
 - Carrier frequency scan: 80 MHz 1 GHz in 1% steps
 - Antenna polarization: Vertical
 - · DUT position: Center aligned to antenna

Devices used in this test:

SiTime, SiT9120AC-1D2-33E156.250000 - MEMS based - 156.25 MHz Epson, EG-2102CA 156.2500M-PHPAL3 - SAW based - 156.25 MHz TXC, BB-156.250MBE-T - 3rd Overtone quartz based - 156.25 MHz Kyocera, KC7050T156.250P30E00 - SAW based - 156.25 MHz Connor Winfield (CW), P123-156.25M - 3rd overtone quartz based - 156.25 MHz SiLabs, Si590AB-BDG - 3rd overtone quartz based - 156.25 MHz

4. 50 mV pk-pk Sinusoidal voltage.

Devices used in this test:

SiTime, SiT8208AI-33-33E-25.000000, MEMS based - 25 MHz NDK, NZ2523SB-25.6M - quartz based - 25.6 MHz Kyocera, KC2016B25M0C1GE00 - quartz based - 25 MHz Epson, SG-310SCF-25M0-MB3 - quartz based - 25 MHz

- 5. Devices used in this test: same as EMS test stated in Note 3.
- 6. Test conditions for shock test:
- MIL-STD-883F Method 2002
- Condition A: half sine wave shock pulse, 500-g, 1ms
- Continuous frequency measurement in 100 µs gate time for 10 seconds
- Devices used in this test: same as EMS test stated in Note 3

7. Additional data, including setup and detailed results, is available upon request to qualified customers. Please contact productsupport@sitime.com.

Best Shock Robustness

SiTime's oscillators can withstand at least 50,000 g shock. They all maintain their electrical performance in operation during shock events. A comparison with quartz devices is shown in Figure 6.

Why is SiTime Best in Class:

- The moving mass of SiTime's MEMS resonators is up to 3000 times smaller than quartz
- Center-anchored MEMS resonator is the most robust design



Figure 6. Shock Robustness^[6]

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Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
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- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
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- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

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